

<b>Notice of References Cited</b>	Application/Control No. 10/012,217	Applicant(s)/Patent Under Reexamination DUDEK ET AL.	
	Examiner Sung H. Pak	Art Unit 2874	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,599,032 B1	07-2003	Kurashima et al.	385/89
	B	US-5,619,604 A	04-1997	Shiflett et al.	385/59
	C	US-5,719,978	02-1998	Kakii et al.	385/89
	D	US-2003/0113071 A1	06-2003	Kim et al.	385/76
	E	US-2003/0072538 A1	04-2003	Jin et al.	385/89
	F	US-6,238,100 B1	05-2001	Sasaki et al.	385/59
	G	US-2002/0076172 A1	06-2002	Meyer et al.	385/91
	H	US-2003/0138219 A1	07-2003	O'Toole et al.	385/92
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.